

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination	
		10/779,793	LEE, SOO-JIN	
Examiner		Art Unit		Page 1 of 1
Prabodh M. Dharia		2629		

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2002/0175908	11-2002	Ide, Shigeo	345/211
*	B	US-6,756,977	06-2004	Ide, Shigeo	345/212
*	C	US-6,388,678	05-2002	Kasahara et al.	345/690
*	D	US-7,075,560	07-2006	Ohe et al.	345/690
*	E	US-2004/0189569	09-2004	Ochi, Yutaka	345/089
*	F	US-6,249,268	06-2001	Tachibana et al.	345/89
*	G	US-2002/0003542	01-2002	TANAKA et al.	345/581
*	H	US-2002/0036650	03-2002	Kasahara et al.	345/639
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	D					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.